Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSVI)

2SK4112

Switching Regulator Applications

Low drain-source ON resistance: RDS (ON) = 0.75 (typ.)

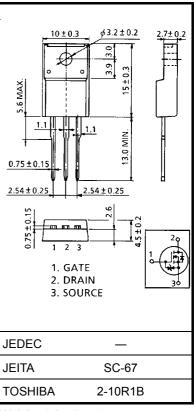
• High forward transfer admittance: $|Y_{fs}| = 5.5S$ (typ.)

Low leakage current: IDSS = 100 \(\mu \) A (VDS = 600 V)

• Enhancement mode: $V_{th} = 2.0 \sim 4.0 \text{ V}$ ($V_{DS} = 10 \text{ V}$, $I_{D} = 1 \text{ mA}$)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	600	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	600	V
Gate-source voltage		V_{GSS}	±30	V
Drain current	DC (Note 1)	I _D	10	
	Pulse (t = 1 ms) (Note 1)	I _{DP}	30	Α
Drain power dissipation (Tc = 25°C)		PD	45	W
Single pulse avalanche energy (Note 2)		E _{AS}	251	mJ
Avalanche current		I _{AR}	10	Α
Repetitive avalanche energy (Note 3)		E _{AR}	4.5	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	-55~150	°C



Weight: 1.9 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	2.78	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Ensure that the channel temperature does not exceed 150 .

Note 2: $V_{DD} = 90 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$, L = 4.39 mH, $I_{AR} = 10 \text{ A}$, $R_G = 25 \Omega$

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

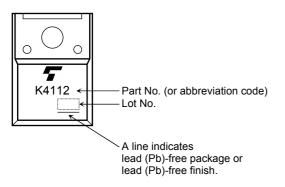
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Gate-source breakdown voltage		V (BR) GSS	$I_G = \pm 10 \mu A, V_{DS} = 0 V$	±30	_	_	V
Drain cut-off current		I _{DSS}	V _{DS} = 600 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source brea	kdown voltage	V (BR) DSS	$I_D = 10$ mA, $V_{GS} = 0$ V	600	_	_	V
Gate threshold vol	tage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source ON r	esistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 4 A	_	0.75	1.0	Ω
Forward transfer a	dmittance	Y _{fs}	V _{DS} = 10 V, I _D = 4 A	1.5	5.5	_	S
Input capacitance		C _{iss}		_	1300		
Reverse transfer capacitance		C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	12		pF
Output capacitance		Coss		_	120		
	Rise time	t _r	$\begin{array}{c c} 10 \text{ V} & \text{I}_D = 4 \text{ A} & \text{V}_{\text{OUT}} \\ \hline V_{\text{GS}} & \text{V} & \text{RL} = 50 \Omega \end{array}$	_	20	_	
Switching time	Turn-on time	t _{on}		_	50		ns
	Fall time	t _f		_	35		
Ĭ	Turn-off time	t _{off}	Duty ≦ 1%, t _W = 10 μs	_	150		
Total gate charge		Qg		_	33	_	
Gate-source charge		Q _{gs}	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	_	18	_	nC
Gate-drain charge		Q _{gd}			15	_	

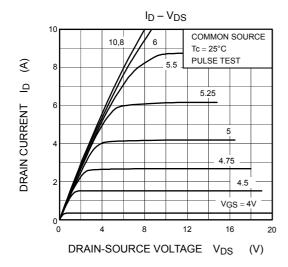
Source-Drain Ratings and Characteristics (Ta = 25°C)

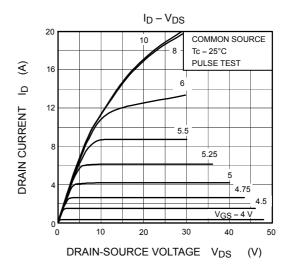
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	10	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	30	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 10 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 10 A, V _{GS} = 0 V,	_	1500	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} /dt = 100 A/μs	_	19	_	μС

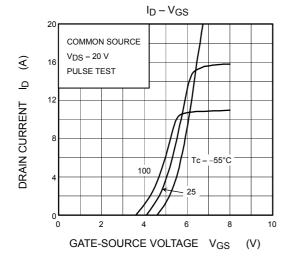
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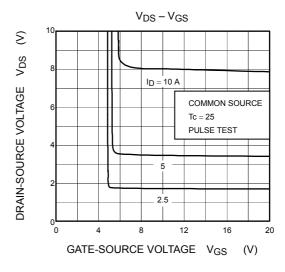


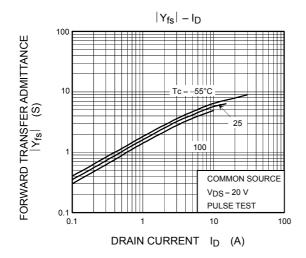
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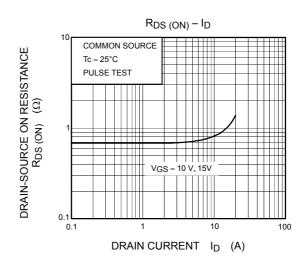




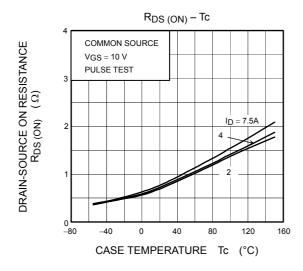


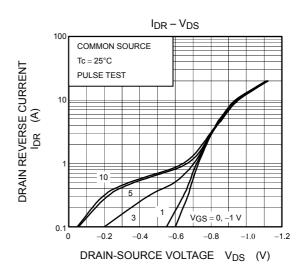


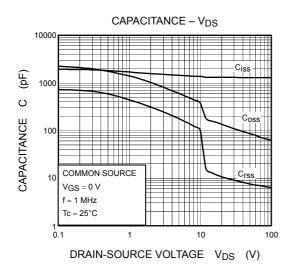


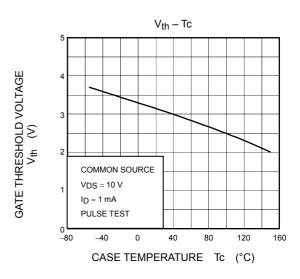


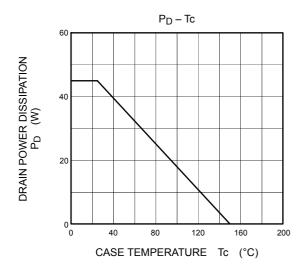
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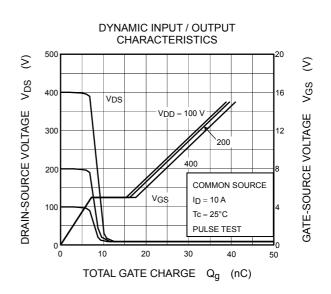




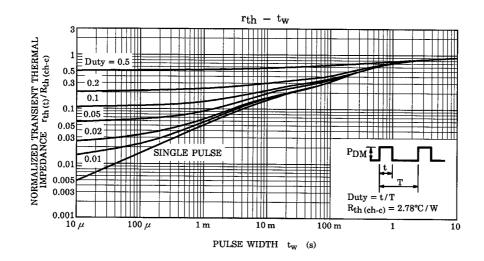


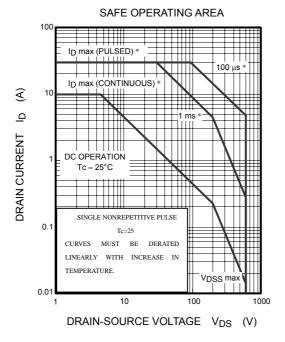


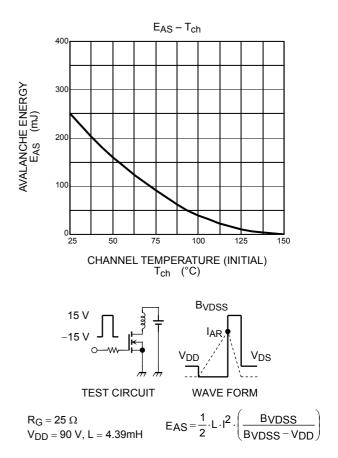




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